

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/044,680 KEEFER ET AL.	
		Examiner	Art Unit DEBBIE M LE	2177 Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,625,585 B1	09-2003	MacCuish et al.	706/10
	B	US-6,493,637 B1	12-2002	Steeg, Evan W.	702/19
	C	US-6,434,542 B1	08-2002	Farmen et al.	706/45
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Choi, Jai W., ANANLYSIS OF CATEGORICAL DATA IN WEIGHTED CLUSTER SAMPLE SURVEYS, Processing of the Survey Research Method Section, American Statistical Association, 1980, pages 573-578.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

